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INTERNATIONAL STANDARD

NORME INTERNATIONALE

Semiconductor devices – Mechanical and climatic test methods – Part 12: Vibration, variable frequency

Dispositifs à semiconducteurs – Méthodes d'essais mécaniques et climatiques – Partie 12: Vibrations, fréquences variables

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CONTENTS

FOREWORD 3
1 Scope 5
2 Normative references 5
3 Terms and definitions 5
4 Test apparatus 5
5 Test method 5
6 Examination and test measurements 6
7 Failure criteria 6
8 Summary 6
Bibliography 7

Table 1 – Test conditions 6

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INTERNATIONAL ELECTROTECHNICAL COMMISSION

SEMICONDUCTOR DEVICES – MECHANICAL AND CLIMATIC TEST METHODS –

Part 12: Vibration, variable frequency

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International Standard IEC 60749-12 has been prepared by IEC technical committee 47: Semiconductor devices.

This second edition cancels and replaces the first edition published in 2002. This edition constitutes a technical revision.

This edition includes the following significant technical changes with respect to the previous edition:

a) alignment with MIL-STD-883J Method 2007, Vibration, variable frequency.

The text of this International Standard is based on the following documents:

CDV	Report on voting
47/2386/CDV	47/2434/RVC

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Full information on the voting for the approval of this International Standard can be found in the report on voting indicated in the above table.

This document has been drafted in accordance with the ISO/IEC Directives, Part 2.

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